

**Search Notes**

Application/Control No.

10/767,555

Examiner

Michael Krofcheck

Applicant(s)/Patent under  
Reexamination

CHOI ET AL.

Art Unit

2186

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor Name Search (PALM)	3/15/2006	MCK
Plus Search	3/10/2006	MCK
EAST Search (USPAT, PGPUB, IBM_TDB, DERWENT) See attached search history	3/23/2006	MCK
711/167-169,154,104-105 365/233,194,189.02, 230.02, 230.08 Text search; See attached search history	3/23/2006	MCK
IEEE Search, see attached search history	3/22/2006	MCK
Additional EAST search; see attached search history	9/7/2006	MCK